

Descriptions

The S78xx series are three-terminal positive regulators providing over 1A output current with internal current limiting, thermal shutdown and safe area protection. These regulators are useful in a wide range of applications. Although they are just fixed voltage regulators, the S78xx series can be used with external components to obtain adjustable voltages and currents.

Features

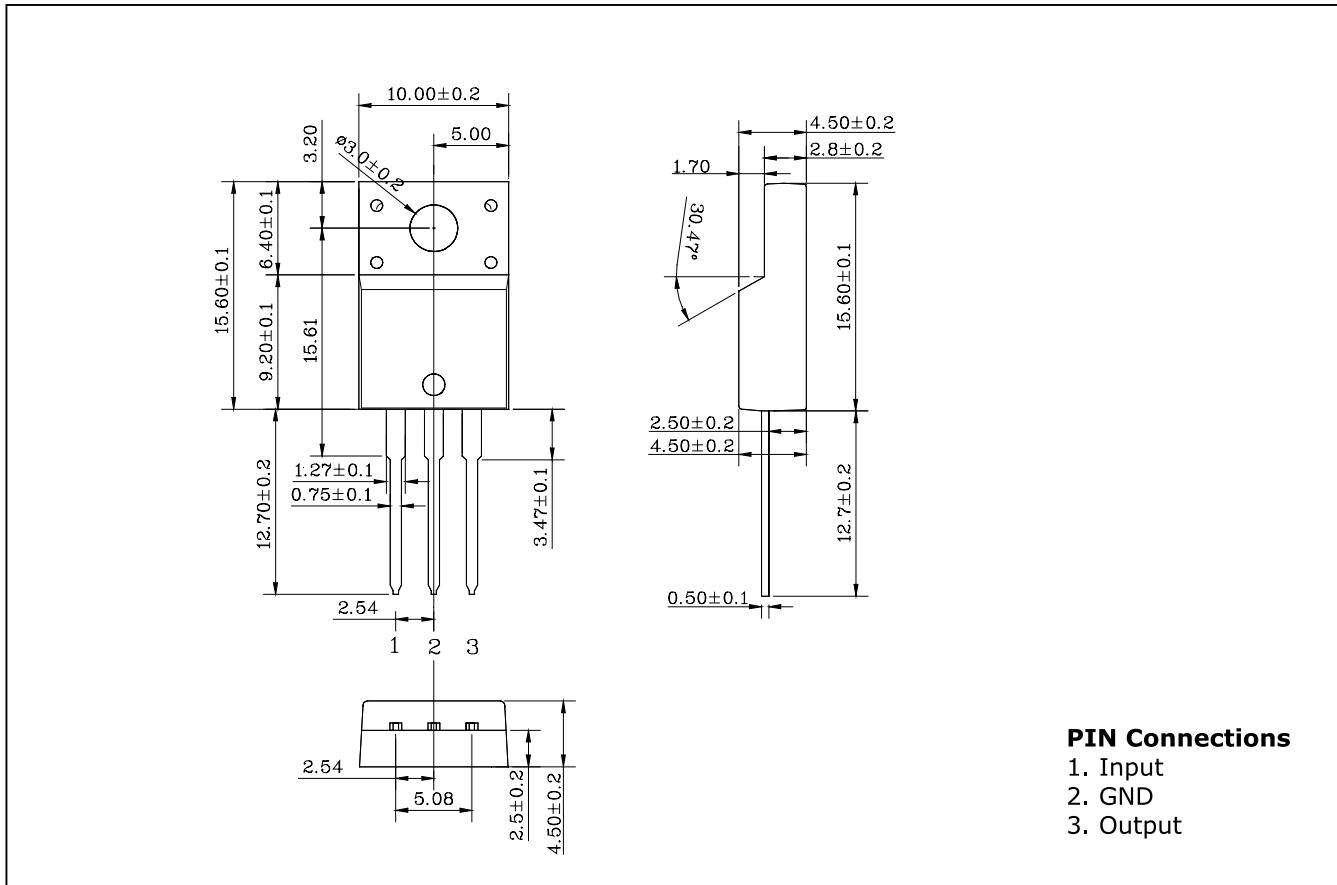
- Internal Short Circuit Current Limiting
- Maximum Output Current (1A Max.)
- Thermal Overload Protection
- Output Transistor Safe Area Protection

Ordering Information

Type NO.	Marking	Package Code
S78xxPI	S78□□PI	TO-220F

□□:Voltage Code (05:5V, 06:6V, 08:8V, 09:9V, 10:10V, 12:12V, 15:15V, 24:24V)

Outline Dimensions

unit : mm


Absolute Maximum Ratings

Ta=25°C

Characteristic	Symbol	Ratings	Unit
Operating Input voltage	V _{IN}	40 (S7824PI)	V
		35 (ALL Others)	V
Power Dissipation (T _C =25°C)	P _D	20.8	W
Power Dissipation (without Heatsink)	P _D	2.0	W
Operating Junction Temperature	T _j	-30 ~ 125	°C
Storage Temperature	T _{stg}	-55 ~ 150	°C

Electrical Characteristics(V_{IN} = 10V, I_{OUT} = 500mA, T_j = 0°C ~ 125°C, Unless otherwise noted)

Characteristic	Symbol	Test Condition	S7805PI			Unit
			Min.	Typ.	Max.	
Output Voltage	V _{OUT}		T _j = 25°C	4.8	5.0	5.2
		I _{OUT} =5mA ~ 1A V _{IN} =7.0V ~ 20V, P _O ≤15W		4.75	5.0	5.25
Line Regulation	ΔV _{OUT}	V _{IN} =7.0V ~ 25V	T _j = 25°C	-	3	100
		V _{IN} =8.0V ~ 12V		-	1	50
Load Regulation	ΔV _{OUT}	I _{OUT} =5mA ~ 1.5A	T _j = 25°C	-	15	100
		I _{OUT} =250mA ~ 750mA		-	5	50
Quiescent Current	I _B		T _j = 25°C	-	4.2	8.0
Quiescent Current Change	ΔI _B	V _{IN} = 7.0V ~ 25V		-	-	1.3
		I _{OUT} = 5mA ~ 1A		-	-	0.5
Output Noise Voltage	V _N	f=10Hz ~ 100KHz	T _j = 25°C	-	40	-
Ripple Rejection Ratio	RR	f=120Hz, V _{IN} = 8.0V ~ 18V		62	78	-
Dropout Voltage	V _D	I _{OUT} =1A	T _j = 25°C	-	2.0	-
Short Circuit Current Limit	I _{SC}		T _j = 25°C	-	0.75	-
Output Voltage Drift	TC _{vo}	I _{OUT} =5mA	T _j = 25°C	-	-1.1	-
Peak Output Current	I _{PK}		T _j = 25°C	-	2.2	-

* Pulse testing techniques are used to maintain the junction temperature as close to the ambient temperature as possible. Thermal effects must be taken into separately.

Electrical Characteristics

($V_{IN} = 11V$, $I_{OUT} = 500mA$, $T_j = 0^\circ C \sim 125^\circ C$, Unless otherwise noted)

Characteristic	Symbol	Test Condition	S7806PI			Unit
			Min.	Typ.	Max.	
Output Voltage	V_{OUT}		$T_j = 25^\circ C$	5.75	6.0	6.25
		$I_{OUT}=5mA \sim 1A$ $V_{IN}=8.0V \sim 21V$, $P_o \leq 15W$		5.7	6.0	6.3
Line Regulation	ΔV_{OUT}	$V_{IN}=8.0V \sim 25V$	$T_j = 25^\circ C$	-	5	120
		$V_{IN}=9.0V \sim 13V$		-	1.5	60
Load Regulation	ΔV_{OUT}	$I_{OUT}=5mA \sim 1.5A$	$T_j = 25^\circ C$	-	14	120
		$I_{OUT}=250mA \sim 750mA$		-	4	60
Quiescent Current	I_B		$T_j = 25^\circ C$	-	4.3	8.0
Quiescent Current Change	ΔI_B	$V_{IN} = 8.0V \sim 25V$		-	-	1.3
		$I_{OUT} = 5mA \sim 1A$		-	-	0.5
Output Noise Voltage	V_N	$f=10Hz \sim 100KHz$	$T_j = 25^\circ C$	-	45	-
Ripple Rejection Ratio	RR	$f=120Hz$, $V_{IN} = 9.0V \sim 19V$		59	75	-
Dropout Voltage	V_D	$I_{OUT}=1A$	$T_j = 25^\circ C$	-	2.0	-
Short Circuit Current Limit	I_{SC}		$T_j = 25^\circ C$	-	0.55	-
Output Voltage Drift	TCvo	$I_{OUT}=5mA$	$T_j = 25^\circ C$	-	-0.8	-
Peak Output Current	I_{PK}		$T_j = 25^\circ C$	-	2.2	-

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Electrical Characteristics

($V_{IN} = 14V$, $I_{OUT} = 500mA$, $T_j = 0^\circ C \sim 125^\circ C$, Unless otherwise noted)

Characteristic	Symbol	Test Condition	S7808PI			Unit
			Min.	Typ.	Max.	
Output Voltage	V_{OUT}		$T_j = 25^\circ C$	7.7	8.0	8.3
		$I_{OUT}=5mA \sim 1A$ $V_{IN}=10.5V \sim 23V$, $P_O \leq 15W$		7.6	8.0	8.4
Line Regulation	ΔV_{OUT}	$V_{IN}=10.5V \sim 25V$	$T_j = 25^\circ C$	-	6	160
		$V_{IN}=11.0V \sim 17V$		-	2	80
Load Regulation	ΔV_{OUT}	$I_{OUT}=5mA \sim 1.5A$	$T_j = 25^\circ C$	-	12	160
		$I_{OUT}=250mA \sim 750mA$		-	4	80
Quiescent Current	I_B		$T_j = 25^\circ C$	-	4.3	8.0
Quiescent Current Change	ΔI_B	$V_{IN} = 10.5V \sim 25V$		-	-	1.0
		$I_{OUT} = 5mA \sim 1A$		-	-	0.5
Output Noise Voltage	V_N	$f=10Hz \sim 100KHz$	$T_j = 25^\circ C$	-	52	-
Ripple Rejection Ratio	RR	$f=120Hz$, $V_{IN} = 11.5V \sim 21.5V$		55	72	-
Dropout Voltage	V_D	$I_{OUT}=1A$	$T_j = 25^\circ C$	-	2.0	-
Short Circuit Current Limit	I_{SC}		$T_j = 25^\circ C$	-	0.45	-
Output Voltage Drift	TCvo	$I_{OUT}=5mA$	$T_j = 25^\circ C$	-	-0.8	-
Peak Output Current	I_{PK}		$T_j = 25^\circ C$	-	2.2	-

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Electrical Characteristics

($V_{IN} = 16V$, $I_{OUT} = 500mA$, $T_j = 0^\circ C \sim 125^\circ C$, Unless otherwise noted)

Characteristic	Symbol	Test Condition	S7809PI			Unit	
			Min.	Typ.	Max.		
Output Voltage	V_{OUT}		$T_j = 25^\circ C$	8.65	9.0	9.35	V
		$I_{OUT} = 5mA \sim 1A$ $V_{IN} = 11.5V \sim 24V$, $P_O \leq 15W$		8.55	9.0	9.45	
Line Regulation	ΔV_{OUT}	$V_{IN} = 11.5V \sim 27V$	$T_j = 25^\circ C$	-	7	180	mV
		$V_{IN} = 13.0V \sim 19V$		-	2	90	
Load Regulation	ΔV_{OUT}	$I_{OUT} = 5mA \sim 1.5A$	$T_j = 25^\circ C$	-	12	180	mV
		$I_{OUT} = 250mA \sim 750mA$		-	4	90	
Quiescent Current	I_B		$T_j = 25^\circ C$	-	4.3	8.0	mA
Quiescent Current Change	ΔI_B	$V_{IN} = 11.5V \sim 27V$		-	-	1.0	mA
		$I_{OUT} = 5mA \sim 1A$		-	-	0.5	
Output Noise Voltage	V_N	$f = 10Hz \sim 100KHz$,	$T_j = 25^\circ C$	-	60	-	μV_{rms}
Ripple Rejection Ratio	RR	$f = 120Hz$, $V_{IN} = 12V \sim 22V$		55	70	-	dB
Dropout Voltage	V_D	$I_{OUT} = 1A$	$T_j = 25^\circ C$	-	2.0	-	V
Short Circuit Current Limit	I_{SC}		$T_j = 25^\circ C$	-	0.4	-	A
Output Voltage Drift	TCvo	$I_{OUT} = 5mA$	$T_j = 25^\circ C$	-	-1.0	-	$mV/^\circ C$
Peak Output Current	I_{PK}		$T_j = 25^\circ C$	-	2.2	-	A

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Electrical Characteristics

($V_{IN} = 17V$, $I_{OUT} = 500mA$, $T_j = 0^\circ C \sim 125^\circ C$, Unless otherwise noted)

Characteristic	Symbol	Test Condition	S7810PI			Unit
			Min.	Typ.	Max.	
Output Voltage	V_{OUT}		$T_j = 25^\circ C$	9.6	10.0	10.4
		$I_{OUT} = 5mA \sim 1A$ $V_{IN} = 12.5V \sim 25V$, $P_0 \leq 15W$		9.5	10.0	10.5
Line Regulation	ΔV_{OUT}	$V_{IN} = 12.5V \sim 28V$	$T_j = 25^\circ C$	-	7	200
		$V_{IN} = 14.0V \sim 20V$		-	2	100
Load Regulation	ΔV_{OUT}	$I_{OUT} = 5mA \sim 1.5A$	$T_j = 25^\circ C$	-	12	200
		$I_{OUT} = 250mA \sim 750mA$		-	4	100
Quiescent Current	I_B		$T_j = 25^\circ C$	-	4.3	8.0
Quiescent Current Change	ΔI_B	$V_{IN} = 12.5V \sim 28V$		-	-	1.0
		$I_{OUT} = 5mA \sim 1A$		-	-	0.5
Output Noise Voltage	V_N	$f = 10Hz \sim 100KHz$	$T_j = 25^\circ C$	-	70	-
Ripple Rejection Ratio	RR	$f = 120Hz$, $V_{IN} = 13V \sim 23V$		55	71	-
Dropout Voltage	V_D	$I_{OUT} = 1A$	$T_j = 25^\circ C$	-	2.0	-
Short Circuit Current Limit	I_{SC}		$T_j = 25^\circ C$	-	0.4	-
Output Voltage Drift	TCvo	$I_{OUT} = 5mA$	$T_j = 25^\circ C$	-	-1.0	-
Peak Output Current	I_{PK}		$T_j = 25^\circ C$	-	2.2	-

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Electrical Characteristics

($V_{IN} = 19V$, $I_{OUT} = 500mA$, $T_j = 0^\circ C \sim 125^\circ C$, Unless otherwise noted)

Characteristic	Symbol	Test Condition	S7812PI			Unit	
			Min.	Typ.	Max.		
Output Voltage	V_{OUT}		$T_j = 25^\circ C$	11.5	12.0	12.5	V
		$I_{OUT} = 5mA \sim 1A$ $V_{IN} = 14.5V \sim 30V$, $P_O \leq 15W$		11.4	12.0	12.6	
Line Regulation	ΔV_{OUT}	$V_{IN} = 14.5V \sim 30V$	$T_j = 25^\circ C$	-	10	240	mV
		$V_{IN} = 16.0V \sim 22V$		-	3	120	
Load Regulation	ΔV_{OUT}	$I_{OUT} = 5mA \sim 1.5A$	$T_j = 25^\circ C$	-	12	240	mV
		$I_{OUT} = 250mA \sim 750mA$		-	4	120	
Quiescent Current	I_B		$T_j = 25^\circ C$	-	4.3	8.0	mA
Quiescent Current Change	ΔI_B	$V_{IN} = 14.5V \sim 30V$		-	-	1.0	mA
		$I_{OUT} = 5mA \sim 1A$		-	-	0.5	
Output Noise Voltage	V_N	$f = 10Hz \sim 100KHz$,	$T_j = 25^\circ C$	-	75	-	μV_{rms}
Ripple Rejection Ratio	RR	$f = 120Hz$, $V_{IN} = 15V \sim 25V$		55	71	-	dB
Dropout Voltage	V_D	$I_{OUT} = 1A$	$T_j = 25^\circ C$	-	2.0	-	V
Short Circuit Current Limit	I_{SC}		$T_j = 25^\circ C$	-	0.35	-	A
Output Voltage Drift	TCvo	$I_{OUT} = 5mA$	$T_j = 25^\circ C$	-	-1.0	-	$mV/^\circ C$
Peak Output Current	I_{PK}		$T_j = 25^\circ C$	-	2.2	-	A

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Electrical Characteristics

($V_{IN} = 23V$, $I_{OUT} = 500mA$, $T_j = 0^\circ C \sim 125^\circ C$, Unless otherwise noted)

Characteristic	Symbol	Test Condition	S7815PI			Unit	
			Min.	Typ.	Max.		
Output Voltage	V_{OUT}		$T_j = 25^\circ C$	14.4	15.0	15.6	V
		$I_{OUT} = 5mA \sim 1A$ $V_{IN} = 17.5V \sim 30V$, $P_O \leq 15W$		14.25	15.0	15.75	
Line Regulation	ΔV_{OUT}	$V_{IN} = 17.5V \sim 30V$	$T_j = 25^\circ C$	-	12	300	mV
		$V_{IN} = 20V \sim 26V$		-	3	150	
Load Regulation	ΔV_{OUT}	$I_{OUT} = 5mA \sim 1.5A$	$T_j = 25^\circ C$	-	12	300	mV
		$I_{OUT} = 250mA \sim 750mA$		-	4	150	
Quiescent Current	I_B		$T_j = 25^\circ C$	-	4.3	8.0	mA
Quiescent Current Change	ΔI_B	$V_{IN} = 17.5V \sim 30V$		-	-	1.0	mA
		$I_{OUT} = 5mA \sim 1A$		-	-	0.5	
Output Noise Voltage	V_N	$f = 10Hz \sim 100KHz$,	$T_j = 25^\circ C$	-	90	-	μV_{rms}
Ripple Rejection Ratio	RR	$f = 120Hz$, $V_{IN} = 18.5V \sim 28.5V$		54	70	-	dB
Dropout Voltage	V_D	$I_{OUT} = 1A$	$T_j = 25^\circ C$	-	2.0	-	V
Short Circuit Current Limit	I_{SC}		$T_j = 25^\circ C$	-	0.23	-	A
Output Voltage Drift	TCvo	$I_{OUT} = 5mA$	$T_j = 25^\circ C$	-	-1.0	-	$mV/^\circ C$
Peak Output Current	I_{PK}		$T_j = 25^\circ C$	-	2.1	-	A

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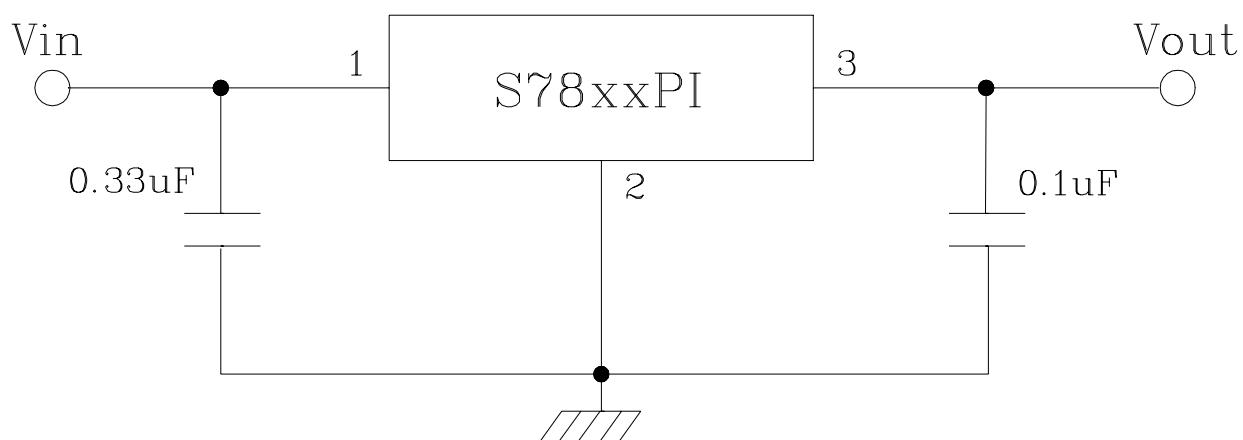
Electrical Characteristics

($V_{IN} = 33V$, $I_{OUT} = 500mA$, $T_j = 0^\circ C \sim 125^\circ C$, Unless otherwise noted)

Characteristic	Symbol	Test Condition	S7824PI			Unit	
			Min.	Typ.	Max.		
Output Voltage	V_{OUT}	$T_j = 25^\circ C$	23.0	24.0	25.0	V	
		$I_{OUT} = 5mA \sim 1A$ $V_{IN} = 27V \sim 38V$, $P_0 \leq 15W$	22.8	24.0	25.2		
Line Regulation	ΔV_{OUT}	$V_{IN} = 27V \sim 38V$	$T_j = 25^\circ C$	-	18	480	mV
		$V_{IN} = 30V \sim 36V$		-	6	240	
Load Regulation	ΔV_{OUT}	$I_{OUT} = 5mA \sim 1.5A$	$T_j = 25^\circ C$	-	12	480	mV
		$I_{OUT} = 250mA \sim 750mA$		-	4	240	
Quiescent Current	I_B		$T_j = 25^\circ C$	-	4.6	8.0	mA
Quiescent Current Change	ΔI_B	$V_{IN} = 27V \sim 38V$		-	-	1.0	mA
		$I_{OUT} = 5mA \sim 1A$		-	-	0.5	
Output Noise Voltage	V_N	$f = 10Hz \sim 100KHz$,	$T_j = 25^\circ C$	-	170	-	μV_{rms}
Ripple Rejection Ratio	RR	$f = 120Hz$, $V_{IN} = 28V \sim 38V$		50	66	-	dB
Dropout Voltage	V_D	$I_{OUT} = 1A$	$T_j = 25^\circ C$	-	2.0	-	V
Short Circuit Current Limit	I_{SC}		$T_j = 25^\circ C$	-	0.15	-	A
Output Voltage Drift	TCvo	$I_{OUT} = 5mA$	$T_j = 25^\circ C$	-	-1.5	-	$mV/^\circ C$
Peak Output Current	I_{PK}		$T_j = 25^\circ C$	-	2.1	-	A

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■ Test circuit



Electrical Characteristic Curves

Fig. 1 V_D vs T_j

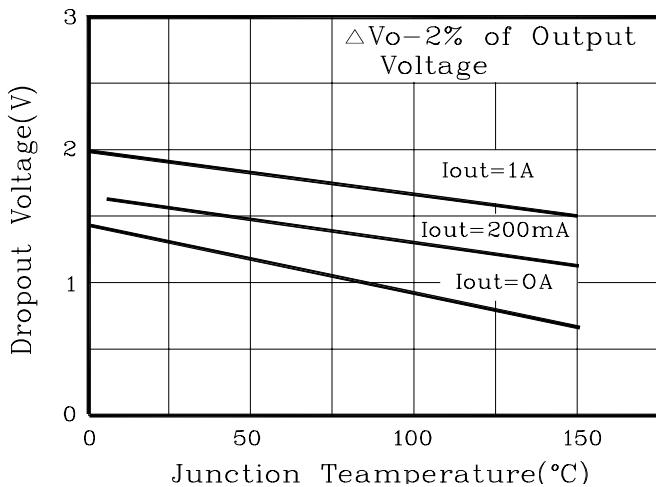


Fig. 2 I_{OUT} vs | V_{IN} - V_{OUT} |

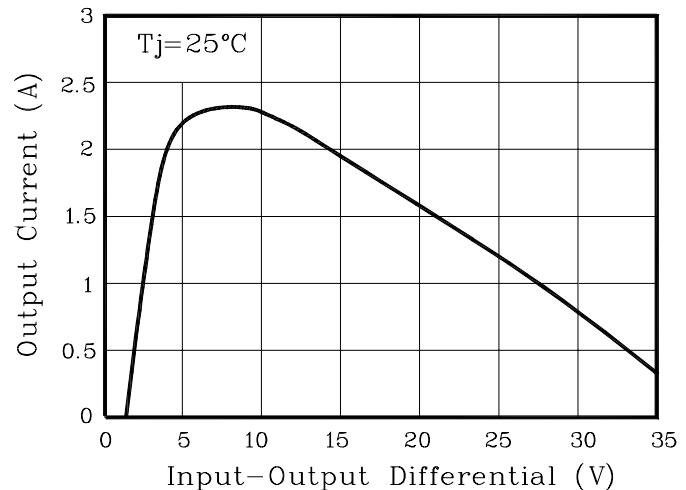


Fig. 3 P_D vs T_a

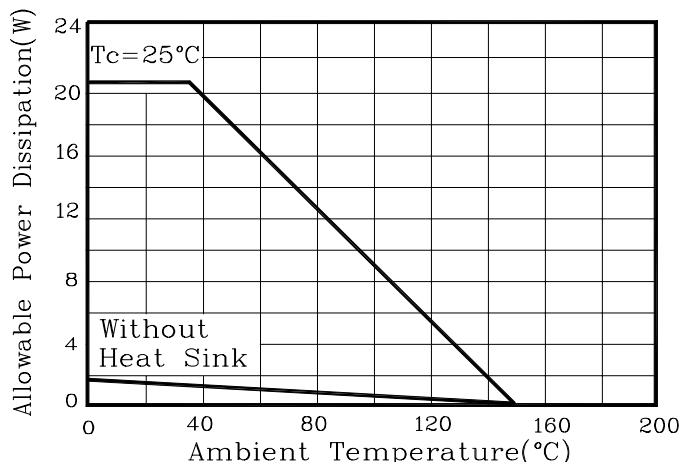


Fig. 4 I_{QC} vs V_{IN}

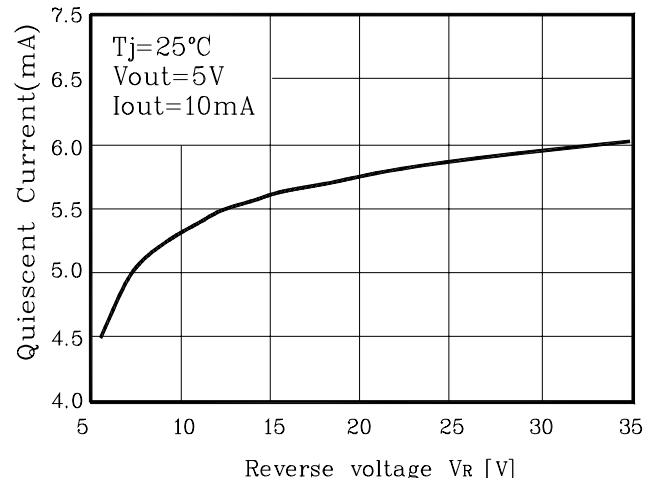


Fig. 5 Ripple Rejection

